NXP USA Inc. - <u>MC9S12E64CPVE Datasheet</u>





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Details

Product Status	Active
Core Processor	HCS12
Core Size	16-Bit
Speed	25MHz
Connectivity	EBI/EMI, I ² C, SCI, SPI
Peripherals	POR, PWM, WDT
Number of I/O	92
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	4K x 8
Voltage - Supply (Vcc/Vdd)	2.35V ~ 2.75V
Data Converters	A/D 16x10b; D/A 2x8b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	112-LQFP
Supplier Device Package	112-LQFP (20x20)
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Figure 1-7. Pin Assignments for 64-QFN



Prescale Value Total Divisor Max		Max. Bus Clock ¹	Min. Bus Clock ²
00000	Divide by 2	4 MHz	1 MHz
00001	Divide by 4	Divide by 4 8 MHz	
00010	Divide by 6 12 MHz 3 MH		3 MHz
00011	Divide by 8	16 MHz	4 MHz
00100	Divide by 10	20 MHz	5 MHz
00101	Divide by 12	24 MHz	6 MHz
00110	Divide by 14	28 MHz	7 MHz
00111	Divide by 16	32 MHz	8 MHz
01000	Divide by 18	36 MHz	9 MHz
01001	Divide by 20	40 MHz	10 MHz
01010	Divide by 22	44 MHz	11 MHz
01011	Divide by 24	48 MHz	12 MHz
01100	Divide by 26	52 MHz	13 MHz
01101	Divide by 28	56 MHz	14 MHz
01110	01110 Divide by 30 60 MHz		15 MHz
01111	Divide by 32	64 MHz	16 MHz
10000	Divide by 34	68 MHz	17 MHz
10001	Divide by 36	72 MHz	18 MHz
10010	Divide by 38	76 MHz	19 MHz
10011	Divide by 40	80 MHz	20 MHz
10100	Divide by 42	84 MHz	21 MHz
10101	Divide by 44	88 MHz	22 MHz
10110	Divide by 46	92 MHz	23 MHz
10111	Divide by 48	96 MHz	24 MHz
11000	Divide by 50	100 MHz	25 MHz
11001	Divide by 52	104 MHz	26 MHz
11010	Divide by 54	108 MHz	27 MHz
11011	Divide by 56	112 MHz	28 MHz
11100	Divide by 58	116 MHz	29 MHz
11101	Divide by 60	120 MHz	30 MHz
11110	Divide by 62	124 MHz	31 MHz
11111	Divide by 64	128 MHz	32 MHz

Table 6-9. Clock Prescaler Va

¹ Maximum ATD conversion clock frequency is 2 MHz. The maximum allowed bus clock frequency is shown in this column.

² Minimum ATD conversion clock frequency is 500 kHz. The minimum allowed bus clock frequency is shown in this column.





6.3.2.8 Reserved Register 0 (ATDTEST0)



Read: Anytime, returns unpredictable values

Write: Anytime in special modes, unimplemented in normal modes

NOTE

Writing to this register when in special modes can alter functionality.

6.3.2.9 ATD Test Register 1 (ATDTEST1)

This register contains the SC bit used to enable special channel conversions.



Read: Anytime, returns unpredictable values for bit 7 and bit 6

Write: Anytime

NOTE

Writing to this register when in special modes can alter functionality.

Table 6-15. ATDTEST1 Field Descriptions

Field	Description
0 SC	 Special Channel Conversion Bit — If this bit is set, then special channel conversion can be selected using CC, CB, and CA of ATDCTL5. Table 6-16 lists the coding. O Special channel conversions disabled 1 Special channel conversions enabled



6.3.2.12 ATD Input Enable Register 0 (ATDDIEN0)



Read: Anytime

Write: anytime

Table 6-19. ATDDIEN0 Field Descriptions

Field	Description
7:0 IEN[15:8]	 ATD Digital Input Enable on Channel Bits — This bit controls the digital input buffer from the analog input pin (ANx) to PTADx data register. 0 Disable digital input buffer to PTADx 1 Enable digital input buffer to PTADx. Note: Setting this bit will enable the corresponding digital input buffer continuously. If this bit is set while simultaneously using it as an analog port, there is potentially increased power consumption because the digital input buffer maybe in the linear region.

6.3.2.13 ATD Input Enable Register 1 (ATDDIEN1)

	7	6	5	4	3	2	1	0
R W	IEN7	IEN6	IEN5	IEN4	IEN3	IEN2	IEN1	IENO
Reset	0	0	0	0	0	0	0	0

Figure 6-15. ATD Input Enable Register 1 (ATDDIEN1)

Read: Anytime

Write: Anytime

Table 6-20. ATDDIEN1 Field Descriptions

Field	Description
7:0 IEN[7:0]	 ATD Digital Input Enable on Channel Bits — This bit controls the digital input buffer from the analog input pin (ANx) to PTADx data register. 0 Disable digital input buffer to PTADx 1 Enable digital input buffer to PTADx. Note: Setting this bit will enable the corresponding digital input buffer continuously. If this bit is set while simultaneously using it as an analog port, there is potentially increased power consumption because the digital input buffer maybe in the linear region.



TDRE flag is set and immediately before writing the next byte to the SCI data register.

If the TE bit is clear and the transmission is complete, the SCI is not the master of the TXD pin

8.4.5 Receiver



Figure 8-14. SCI Receiver Block Diagram

8.4.5.1 Receiver Character Length

The SCI receiver can accommodate either 8-bit or 9-bit data characters. The state of the M bit in SCI control register 1 (SCICR1) determines the length of data characters. When receiving 9-bit data, bit R8 in SCI data register high (SCIDRH) is the ninth bit (bit 8).

8.4.5.2 Character Reception

During an SCI reception, the receive shift register shifts a frame in from the RXD pin. The SCI data register is the read-only buffer between the internal data bus and the receive shift register.

After a complete frame shifts into the receive shift register, the data portion of the frame transfers to the SCI data register. The receive data register full flag, RDRF, in SCI status register 1 (SCISR1) becomes set,



9.4.2 Slave Mode

The SPI operates in slave mode when the MSTR bit in SPI Control Register1 is clear.

- SCK Clock
 - In slave mode, SCK is the SPI clock input from the master.
- MISO and MOSI Pins

In slave mode, the function of the serial data output pin (MISO) and serial data input pin (MOSI) is determined by the SPC0 bit and BIDIROE bit in SPI Control Register 2.

• $\overline{\text{SS}}$ Pin

The \overline{SS} pin is the slave select input. Before a data transmission occurs, the \overline{SS} pin of the slave SPI must be low. \overline{SS} must remain low until the transmission is complete. If \overline{SS} goes high, the SPI is forced into idle state.

The \overline{SS} input also controls the serial data output pin, if \overline{SS} is high (not selected), the serial data output pin is high impedance, and, if \overline{SS} is low the first bit in the SPI Data Register is driven out of the serial data output pin. Also, if the slave is not selected (\overline{SS} is high), then the SCK input is ignored and no internal shifting of the SPI shift register takes place.

Although the SPI is capable of duplex operation, some SPI peripherals are capable of only receiving SPI data in a slave mode. For these simpler devices, there is no serial data out pin.

NOTE

When peripherals with duplex capability are used, take care not to simultaneously enable two receivers whose serial outputs drive the same system slave's serial data output line.

As long as no more than one slave device drives the system slave's serial data output line, it is possible for several slaves to receive the same transmission from a master, although the master would not receive return information from all of the receiving slaves.

If the CPHA bit in SPI Control Register 1 is clear, odd numbered edges on the SCK input cause the data at the serial data input pin to be latched. Even numbered edges cause the value previously latched from the serial data input pin to shift into the LSB or MSB of the SPI shift register, depending on the LSBFE bit.

If the CPHA bit is set, even numbered edges on the SCK input cause the data at the serial data input pin to be latched. Odd numbered edges cause the value previously latched from the serial data input pin to shift into the LSB or MSB of the SPI shift register, depending on the LSBFE bit.

When CPHA is set, the first edge is used to get the first data bit onto the serial data output pin. When CPHA is clear and the \overline{SS} input is low (slave selected), the first bit of the SPI data is driven out of the serial data output pin. After the eighth shift, the transfer is considered complete and the received data is transferred into the SPI Data Register. To indicate transfer is complete, the SPIF flag in the SPI Status Register is set.

NOTE

A change of the bits CPOL, CPHA, SSOE, LSBFE, MODFEN, SPC0 and BIDIROE with SPC0 set in slave mode will corrupt a transmission in progress and has to be avoided.



Chapter 11 Pulse Width Modulator with Fault Protection (PMF15B6CV2)

11.3.2.2 PMF Configure 1 Register (PMFCFG1)

Module Base + 0x0001



Figure 11-5. PMF Configure 1 Register (PMFCFG1)

Read anytime. This register cannot be modified after the WP bit is set.

A normal PWM output or positive polarity means that the PWM channel outputs high when the counter value is smaller than or equal to the pulse width value and outputs low otherwise. An inverted output or negative polarity means that the PWM channel outputs low when the counter value is smaller than or equal to the pulse width value and outputs low when the counter value is smaller than or equal to the pulse width value and outputs low when the counter value is smaller than or equal to the pulse width value and outputs low when the counter value is smaller than or equal to the pulse width value and outputs high otherwise.

Table 11-3. PMFC	FG1 Field	Descriptions
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Field	Description
7 ENHA	 Enable Hardware Acceleration — This bit enables writing to the VLMODE[1:0], SWAPC, SWAPB, and SWAPA bits in the PMFCFG3 register. This bit cannot be modified after the WP bit is set. 0 Disable writing to VLMODE[1:0], SWAPC, SWAPB, and SWAPA bits 1 Enable writing to VLMODE[1:0], SWAPC, SWAPB, and SWAPA bits
5 BOTNEGC	 Pair C Bottom-side PWM Polarity — This bit determines the polarity for Pair C bottom-side PWM (PWM5). This bit cannot be modified after the WP bit is set. 0 Positive PWM5 polarity 1 Negative PWM5 polarity
4 TOPNEGC	 Pair C Top-side PWM Polarity — This bit determines the polarity for Pair C top-side PWM (PWM4). This bit cannot be modified after the WP bit is set. 0 Positive PWM4 polarity 1 Negative PWM4 polarity
3 BOTNEGB	 Pair B Bottom-side PWM Polarity — This bit determines the polarity for Pair B bottom-side PWM (PWM3). This bit cannot be modified after the WP bit is set. 0 Positive PWM3 polarity 1 Negative PWM3 polarity
2 TOPNEGB	 Pair B Top-side PWM Polarity — This bit determines the polarity for Pair B top-side PWM (PWM2). This bit cannot be modified after the WP bit is set. 0 Positive PWM2 polarity 1 Negative PWM2 polarity
1 BOTNEGA	 Pair A Bottom-side PWM Polarity — This bit determines the polarity for Pair A bottom-side PWM (PWM1). This bit cannot be modified after the WP bit is set. 0 Positive PWM1 polarity 1 Negative PWM1 polarity
0 TOPNEGA	 Pair A Top-side PWM Polarity — This bit determines the polarity for Pair A top-side PWM (PWM0). This bit cannot be modified after the WP bit is set. 0 Positive PWM0 polarity 1 Negative PWM0 polarity



Chapter 11 Pulse Width Modulator with Fault Protection (PMF15B6CV2)

11.3.2.12 PMF Deadtime Sample Register (PMFDTMS)

Module Base + 0x000E



Figure 11-18. PMF Deadtime Sample Register (PMFDTMS))

Read anytime and writes have no effect.

Table 11-16. PMFDTMS Field Description
--

Field	Description
5–0 DT[5:0]	PMF Deadtime Sample Bits — The DTx bits are grouped in pairs, DT0 and DT1, DT2 and DT3, DT4, and DT5. Each pair reflects the corresponding \overline{ISx} pin value as sampled at the end of deadtime.

11.3.2.13 PMF Correction Control Register (PMFCCTL)

Module Base + 0x000F



Figure 11-19. PMF Correction Control Register (PMFCCTL)

Read and write anytime.

Table 11-17. PMFCCTL Field Descriptions

Field	Description
5–4 ISENS	 Current Status Sensing Method — This field selects the top/bottom correction scheme, illustrated in Table 11-18. Note: Assume the user will provide current sensing circuitry causing the voltage at the corresponding input pin to be low for positive current and high for negative current. In addition, it assumes the top PWMs are PWM 0, 2, and 4 while the bottom PWMs are PWM 1, 3, and 5. Note: The ISENS bits are not buffered. Changing the current status sensing method can affect the present PWM cycle.



Chapter 11 Pulse Width Modulator with Fault Protection (PMF15B6CV2)

11.4.7.3 Reload Flag

With a reload opportunity, regardless an actual reload occurs as determined by LDOK bit, the PWMF reload flag is set. If the PWM reload interrupt enable bit, PWMRIE is set, the PWMF flag generates CPU interrupt requests allowing software to calculate new PWM parameters in real time. When PWMRIE is not set, reloads still occur at the selected reload rate without generating CPU interrupt requests.



Figure 11-67. PWMRF Reload Interrupt Request



Figure 11-68. Full-Cycle Center-Aligned PWM Value Loading



Figure 11-69. Full-Cycle Center-Aligned Modulus Loading

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Field	Description
2 PCLK2	Pulse Width Channel 2 Clock Select0 Clock B is the clock source for PWM channel 2.1 Clock SB is the clock source for PWM channel 2.
1 PCLK1	Pulse Width Channel 1 Clock Select0 Clock A is the clock source for PWM channel 1.1 Clock SA is the clock source for PWM channel 1.
0 PCLK0	Pulse Width Channel 0 Clock Select0 Clock A is the clock source for PWM channel 0.1 Clock SA is the clock source for PWM channel 0.

12.3.2.4 PWM Prescale Clock Select Register (PWMPRCLK)

This register selects the prescale clock source for clocks A and B independently.



Figure 12-6. PWM Prescaler Clock Select Register (PWMPRCLK)

Read: anytime

Write: anytime

NOTE

PCKB2–PCKB0 and PCKA2–PCKA0 register bits can be written anytime. If the clock prescale is changed while a PWM signal is being generated, a truncated or stretched pulse can occur during the transition.

Table 12-5. PWMPRCLK Field Descriptions

Field	Description
6:5 PCKB[2:0]	Prescaler Select for Clock B — Clock B is 1 of two clock sources which can be used for channels 2 or 3. These three bits determine the rate of clock B, as shown in Table 12-6.
2:0 PCKA[2:0]	Prescaler Select for Clock A — Clock A is 1 of two clock sources which can be used for channels 0, 1, 4, or 5. These three bits determine the rate of clock A, as shown in Table 12-7.

PCKB2	PCKB1	PCKB0	Value of Clock B
0	0	0	Bus Clock
0	0	1	Bus Clock / 2
0	1	0	Bus Clock / 4
0	1	1	Bus Clock / 8
1	0	0	Bus Clock / 16
1	0	1	Bus Clock / 32
1	1	0	Bus Clock / 64
1	1	1	Bus Clock / 128

Table 12-6. Clock B Prescaler Se

Table 12-7. Clock A Prescaler Selects

PCKA2	PCKA1	PCKA0	Value of Clock A
0	0	0	Bus Clock
0	0	1	Bus Clock / 2
0	1	0	Bus Clock / 4
0	1	1	Bus Clock / 8
1	0	0	Bus Clock / 16
1	0	1	Bus Clock / 32
1	1	0	Bus Clock / 64
1	1	1	Bus Clock / 128

12.3.2.5 PWM Center Align Enable Register (PWMCAE)

The PWMCAE register contains six control bits for the selection of center aligned outputs or left aligned outputs for each PWM channel. If the CAEx bit is set to a 1, the corresponding PWM output will be center aligned. If the CAEx bit is cleared, the corresponding PWM output will be left aligned. Reference Section 12.4.2.5, "Left Aligned Outputs," and Section 12.4.2.6, "Center Aligned Outputs," for a more detailed description of the PWM output modes.



Figure 12-7. PWM Center Align Enable Register (PWMCAE)

Read: anytime

Write: anytime

NOTE

Write these bits only when the corresponding channel is disabled.

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Chapter 12 Pulse-Width Modulator (PWM8B6CV1)

12.4.1.3 Clock Select

Each PWM channel has the capability of selecting one of two clocks. For channels 0, 1, 4, and 5 the clock choices are clock A or clock SA. For channels 2 and 3 the choices are clock B or clock SB. The clock selection is done with the PCLKx control bits in the PWMCLK register.

NOTE

Changing clock control bits while channels are operating can cause irregularities in the PWM outputs.

12.4.2 PWM Channel Timers

The main part of the PWM module are the actual timers. Each of the timer channels has a counter, a period register and a duty register (each are 8 bit). The waveform output period is controlled by a match between the period register and the value in the counter. The duty is controlled by a match between the duty register and the counter value and causes the state of the output to change during the period. The starting polarity of the output is also selectable on a per channel basis. Figure 12-35 shows a block diagram for PWM timer.



PWMEx



MC9S12E128 Data Sheet, Rev. 1.07



Chapter 13 Timer Module (TIM16B4CV1)

13.1.3 Block Diagrams



Figure 13-1. TIM16B4CV1 Block Diagram



14.5 Resets

This subsection describes how VREG3V3V2 controls the reset of the MCU. The reset values of registers and signals are provided in Section 14.3, "Memory Map and Register Definition". Possible reset sources are listed in Table 14-4.

Reset Source	Local Enable
Power-on reset	Always active
Low-voltage reset	Available only in full-performance mode

Table 14-4. VREG3V3V2 — Reset Sources

14.5.1 Power-On Reset

During chip power-up the digital core may not work if its supply voltage V_{DD} is below the POR deassertion level (V_{PORD}). Therefore, signal POR which forces the other blocks of the device into reset is kept high until V_{DD} exceeds V_{PORD} . Then POR becomes low and the reset generator of the device continues the start-up sequence. The power-on reset is active in all operation modes of VREG3V3V2.

14.5.2 Low-Voltage Reset

For details on low-voltage reset see Section 14.4.6, "LVR - Low-Voltage Reset".

14.6 Interrupts

This subsection describes all interrupts originated by VREG3V3V2.

The interrupt vectors requested by VREG3V3V2 are listed in Table 14-5. Vector addresses and interrupt priorities are defined at MCU level.

Table 14-5. VREG3V3V2 — Interrupt Vectors

Interrupt Source	Local Enable
Low Voltage Interrupt (LVI)	LVIE = 1; Available only in full-performance mode

14.6.1 LVI — Low-Voltage Interrupt

In FPM VREG3V3V2 monitors the input voltage V_{DDA} . Whenever V_{DDA} drops below level V_{LVIA} the status bit LVDS is set to 1. Vice versa, LVDS is reset to 0 when V_{DDA} rises above level V_{LVID} . An interrupt, indicated by flag LVIF = 1, is triggered by any change of the status bit LVDS if interrupt enable bit LVIE = 1.

NOTE

On entering the reduced-power mode, the LVIF is not cleared by the VREG3V3V2.



Chapter 15 Background Debug Module (BDMV4)

15.4.8 Hardware Handshake Abort Procedure

The abort procedure is based on the SYNC command. In order to abort a command, which had not issued the corresponding ACK pulse, the host controller should generate a low pulse in the BKGD pin by driving it low for at least 128 serial clock cycles and then driving it high for one serial clock cycle, providing a speedup pulse. By detecting this long low pulse in the BKGD pin, the target executes the SYNC protocol, see Section 15.4.9, "SYNC — Request Timed Reference Pulse," and assumes that the pending command and therefore the related ACK pulse, are being aborted. Therefore, after the SYNC protocol has been completed the host is free to issue new BDM commands.

Although it is not recommended, the host could abort a pending BDM command by issuing a low pulse in the BKGD pin shorter than 128 serial clock cycles, which will not be interpreted as the SYNC command. The ACK is actually aborted when a falling edge is perceived by the target in the BKGD pin. The short abort pulse should have at least 4 clock cycles keeping the BKGD pin low, in order to allow the falling edge to be detected by the target. In this case, the target will not execute the SYNC protocol but the pending command will be aborted along with the ACK pulse. The potential problem with this abort procedure is when there is a conflict between the ACK pulse and the short abort pulse. In this case, the target may not perceive the abort pulse. The worst case is when the pending command is a read command (i.e., READ_BYTE). If the abort pulse is not perceived by the target the host to retrieve the accessed memory byte. In this case, host and target will run out of synchronism. However, if the command to be aborted is not a read command the short abort pulse could be used. After a command is aborted the target assumes the next falling edge, after the abort pulse, is the first bit of a new BDM command.

NOTE

The details about the short abort pulse are being provided only as a reference for the reader to better understand the BDM internal behavior. It is not recommended that this procedure be used in a real application.

Because the host knows the target serial clock frequency, the SYNC command (used to abort a command) does not need to consider the lower possible target frequency. In this case, the host could issue a SYNC very close to the 128 serial clock cycles length. Providing a small overhead on the pulse length in order to assure the SYNC pulse will not be misinterpreted by the target. See Section 15.4.9, "SYNC — Request Timed Reference Pulse."

Figure 15-12 shows a SYNC command being issued after a READ_BYTE, which aborts the READ_BYTE command. Note that, after the command is aborted a new command could be issued by the host computer.

NOTE

Figure 15-12 does not represent the signals in a true timing scale



Chapter 15 Background Debug Module (BDMV4)



Figure 15-12. ACK Abort Procedure at the Command Level

Figure 15-13 shows a conflict between the ACK pulse and the SYNC request pulse. This conflict could occur if a POD device is connected to the target BKGD pin and the target is already in debug active mode. Consider that the target CPU is executing a pending BDM command at the exact moment the POD is being connected to the BKGD pin. In this case, an ACK pulse is issued along with the SYNC command. In this case, there is an electrical conflict between the ACK speedup pulse and the SYNC pulse. Because this is not a probable situation, the protocol does not prevent this conflict from happening.



Figure 15-13. ACK Pulse and SYNC Request Conflict

NOTE

This information is being provided so that the MCU integrator will be aware that such a conflict could eventually occur.

The hardware handshake protocol is enabled by the ACK_ENABLE and disabled by the ACK_DISABLE BDM commands. This provides backwards compatibility with the existing POD devices which are not able to execute the hardware handshake protocol. It also allows for new POD devices, that support the hardware handshake protocol, to freely communicate with the target device. If desired, without the need for waiting for the ACK pulse.



Table 16-3. DBGC1 Field Descriptions (continued)

Field	Description
3 DBGBRK	 DBG Breakpoint Enable Bit — The DBGBRK bit controls whether the debugger will request a breakpoint based on comparator A and B to the CPU upon completion of a tracing session. Please refer to Section 16.4.3, "Breakpoints," for further details. 0 CPU break request not enabled 1 CPU break request enabled
1:0 CAPMOD	Capture Mode Field — See Table 16-4 for capture mode field definitions. In LOOP1 mode, the debugger will automatically inhibit redundant entries into capture memory. In detail mode, the debugger is storing address and data for all cycles except program fetch (P) and free (f) cycles. In profile mode, the debugger is returning the address of the last instruction executed by the CPU on each access of trace buffer address. Refer to Section 16.4.2.6, "Capture Modes," for more information.

CAPMOD	Description
00	Normal
01	LOOP1
10	DETAIL
11	PROFILE

Table 16-4. CAPMOD Encoding



Pin Name	Pin Eurotions	Description
	FINFUNCTIONS	
PE5/IPIPE0/MODA	MODA	At the rising edge on RESET, the state of this pin is registered into the MODA bit to set the mode.
	PE5	General-purpose I/O pin, see PORTE and DDRE registers.
	IPIPE0	Instruction pipe status bit 0, enabled by PIPOE bit in PEAR.
PE4/ECLK	PE4	General-purpose I/O pin, see PORTE and DDRE registers.
	ECLK	Bus timing reference clock, can operate as a free-running clock at the system clock rate or to produce one low-high clock per visible access, with the high period stretched for slow accesses. ECLK is controlled by the NECLK bit in PEAR, the IVIS bit in MODE, and the ESTR bit in EBICTL.
PE3/LSTRB/ TAGLO	PE3	General-purpose I/O pin, see PORTE and DDRE registers.
	LSTRB	Low strobe bar, 0 indicates valid data on D7–D0.
	SZ8	In special peripheral mode, this pin is an input indicating the size of the data transfer ($0 = 16$ -bit; $1 = 8$ -bit).
	TAGLO	In expanded wide mode or emulation narrow modes, when instruction tagging is on and low strobe is enabled, a 0 at the falling edge of E tags the low half of the instruction word being read into the instruction queue.
PE2/R/W	PE2	General-purpose I/O pin, see PORTE and DDRE registers.
	R/W	Read/write, indicates the direction of internal data transfers. This is an output except in special peripheral mode where it is an input.
PE1/IRQ	PE1	General-purpose input-only pin, can be read even if IRQ enabled.
	ĪRQ	Maskable interrupt request, can be level sensitive or edge sensitive.
PE0/XIRQ	PE0	General-purpose input-only pin.
	XIRQ	Non-maskable interrupt input.
PK7/ECS	PK7	General-purpose I/O pin, see PORTK and DDRK registers.
	ECS	Emulation chip select
PK6/XCS	PK6	General-purpose I/O pin, see PORTK and DDRK registers.
	XCS	External data chip select
PK5/X19	PK5–PK0	General-purpose I/O pins, see PORTK and DDRK registers.
nru PK0/X14	X19–X14	Memory expansion addresses

Table 18-1. External System Pins Associated With MEBI (c	continued)
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Detailed descriptions of these pins can be found in the device overview chapter.



A.6 ATD Characteristics

This section describes the characteristics of the analog to digital converter.

The ATD is specified and tested for both the 3.3V and 5V range. For ranges between 3.3V and 5V the ATD accuracy is generally the same as in the 3.3V range but is not tested in this range in production test.

A.6.1 ATD Operating Characteristics — 5V Range

The Table A-19 shows conditions under which the ATD operates.

The following constraints exist to obtain full-scale, full range results:

 $VSSA \le VRL \le VIN \le VRH \le VDDA$. This constraint exists since the sample buffer amplifier can not drive beyond the power supply levels that it ties to. If the input level goes outside of this range it will effectively be clipped.

Conditions are shown in Table A-4 unless otherwise noted. Supply Voltage 5V-10% <= VDDA <=5V+10%							
Num	С	Rating	Symbol	Min	Тур	Мах	Unit
1	D	Reference Potential					
		Low High	V _{RL} V _{RH}	V _{SSA} V _{DDA/2}	—	V _{DDA/2} V _{DDA}	V V
2	С	Differential Reference Voltage ¹	$V_{RH} - V_{RL}$	4.75	5.0	5.25	V
3	D	ATD Clock Frequency	f _{ATDCLK}	0.5	—	2.0	MHz
4	D	ATD 10-Bit Conversion Period					
		Clock Cycles ²	N _{CONV10}	14	_	28	Cycles
		Conv, Time at 2.0MHz ATD Clock f _{ATDCLK}	T _{CONV10}	7		14	μs
		Conv, Time at 4.0MHz ³ ATD Clock f _{ATDCLK}	T _{CONV10}	3.5	—	7	μs
5	D	ATD 8-Bit Conversion Period					
		Clock Cycles ¹	N _{CONV8}	12		26	Cycles
		Conv, Time at 2.0MHz ATD Clock f _{ATDCLK}	T _{CONV8}	6	—	13	μs
6	D	Stop Recovery Time (V _{DDA} = 5.0 Volts)	t _{SR}	_	_	20	μs
7	Р	Reference Supply current	I _{REF}	_	_	0.375	mA

Table A-19. 5V ATD Operating Characteristics

¹ Full accuracy is not guaranteed when differential voltage is less than 4.75V

² The minimum time assumes a final sample period of 2 ATD clocks cycles while the maximum time assumes a final sample period of 16 ATD clocks.

³ Reduced accuracy see Table A-22 and Table A-23.

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